

# ACPL-P480 and ACPL-W480

## High CMR Intelligent Power Module and Gate Drive Interface Optocoupler



### Data Sheet



Lead (Pb) Free  
RoHS 6 fully compliant

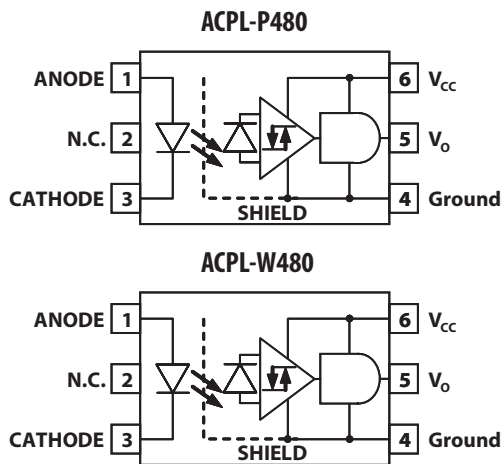
RoHS 6 fully compliant options available;  
-xxxE denotes a lead-free product



### Description

The ACPL-P480 and ACPL-W480 fast speed optocouplers contain a GaAsP LED and photo detector with built-in Schmitt trigger to provide logic-compatible waveforms, eliminating the need for additional wave shaping. The totem pole output eliminates the need for a pull up resistor and allows for direct drive Intelligent Power Module or gate drive. Minimized propagation delay difference between devices make these optocouplers excellent solutions for improving inverter efficiency through reduced switching dead time.

### Functional Diagrams



Note: A 0.1  $\mu$ F bypass capacitor must be connected between pins 4 and 6.

### Truth Table (Positive Logic)

LED	V <sub>O</sub>
ON	HIGH
OFF	LOW

### Features

- Performance Specified for Common IPM Applications Over Industrial Temperature Range.
- Short Maximum Propagation Delays
- Minimized Pulse Width Distortion (PWD)
- Very High Common Mode Rejection (CMR)
- Hysteresis
- Totem Pole Output (No Pull-up Resistor Required)
- Available in Stretched SO-6 package.
- Safety Approval:

UL Recognized with 3750 V<sub>rms</sub> for 1 minute (5000 V<sub>rms</sub> for 1 minute for all ACPL-W480 devices and Option 020 device for ACPL-P480) per UL1577.

CSA Approved.

IEC/EN/DIN EN 60747-5-5 Approved:

V<sub>IORM</sub> = 891 V<sub>peak</sub> for ACPL-P480, and V<sub>IORM</sub> = 1140 V<sub>peak</sub> for ACPL-W480.

### Specifications

- Wide operating temperature range: -40°C to 100°C.
- Maximum propagation delay t<sub>PHL</sub> / t<sub>PLH</sub> = 350 ns
- Maximum Pulse Width Distortion (PWD) = 250 ns.
- Propagation Delay Difference: Min. -100 ns, Max. 250 ns
- Wide Operating V<sub>CC</sub> Range: 4.5 to 20 Volts
- 20 kV/ $\mu$ s minimum common mode rejection (CMR) at V<sub>CM</sub> = 1000 V.

### Applications

- IPM Interface Isolation
- Isolated IGBT/MOSFET Gate Drive
- AC and Brushless DC Motor Drives
- Industrial Inverters
- General Digital Isolation

**CAUTION:** It is advised that normal static precautions be taken in handling and assembly of this component to prevent damage and/or degradation which may be induced by ESD.

## Ordering Information

ACPL-P480 is UL Recognized with 3750 Vrms for 1 minute and ACPL-W480 is UL Recognized with 5000 Vrms for 1 minute per UL1577. Both are approved under CSA Component Acceptance Notice #5, File CA 88324.

Part number	Option	Package	Surface Mount	Tape & Reel	UL 1577 5000VRMS / 1 Minute Rating	IEC/EN/DIN EN 60747-5-5	Quantity	
	RoHS Compliant							
ACPL-P480	-000E	7mm Stretched SO-6	X				100 per tube	
	-500E		X	X			1000 per reel	
	-020E		X			X	100 per reel	
	-520E		X	X		X	1000 per reel	
	-060E		X				X	100 per tube
	-560E		X	X			X	1000 per reel
ACPL-W480	-000E	8mm Stretched SO-6	X		X		100 per tube	
	-500E		X	X	X		1000 per reel	
	-060E		X			X	X	100 per tube
	-560E		X	X	X	X	X	1000 per reel

To order, choose a part number from the part number column and combine with the desired option from the option column to form an order entry.

Example 1:

ACPL-P480-560E to order product of Stretched SO-6 package in Tape and Reel packaging with IEC/EN/DIN EN 60747-5-5 Safety Approval in RoHS compliant.

Example 2:

ACPL-P480-000E to order product of Stretched SO-6 package in tube packaging and RoHS compliant.

Option datasheets are available. Contact your Avago sales representative or authorized distributor for information.



## Solder Reflow Profile

Recommended reflow condition as per JEDEC Standard, J-STD-020 (latest revision). Non-Halide Flux should be used.

## Regulatory Information

The ACPL-P480 and ACPL-W480 are approved by the following organizations:

### IEC/EN/DIN EN 60747-5-5 (Option 60 only)

Approval under:

IEC 60747-5-5 : 2007

EN 60747-5-5 : 2011

DIN EN 60747-5-5 (VDE 0884-5) : 2011-11

### CSA

Approval under CSA Component Acceptance Notice #5,  
File CA 88324.

### UL

ACPL-P480: Approval under UL 1577, component recognition program up to  $V_{ISO} = 3750 V_{RMS}$ . File E55361.

ACPL-W480 and ACPL-P480 (option 020): Approval under UL 1577, component recognition program up to  $V_{ISO} = 5000 V_{RMS}$ . File E55361.

**Table 1. IEC/EN/DIN EN 60747-5-5 Insulation Characteristics\* (Option 060)**

Description	Symbol	Characteristic		Unit
		ACPL-P480	ACPL-W480	
Installation classification per DIN VDE 0110/39, Table 1 for rated mains voltage $\leq 300 V_{rms}$ for rated mains voltage $\leq 450 V_{rms}$ for rated mains voltage $\leq 600 V_{rms}$		I - IV I - III I - III	I - IV I - IV I - IV	
Climatic Classification		55/100/21		
Pollution Degree (DIN VDE 0110/39)		2		
Maximum Working Insulation Voltage	$V_{IORM}$	891	1140	Vpeak
Input to Output Test Voltage, Method b* $V_{IORM} \times 1.875 = V_{PR}$ , 100% Production Test with $t_m = 1$ sec, Partial discharge $< 5$ pC	$V_{PR}$	1670	2137	Vpeak
Input to Output Test Voltage, Method a* $V_{IORM} \times 1.6 = V_{PR}$ , Type and Sample Test with $t_m = 10$ sec, Partial discharge $< 5$ pC	$V_{PR}$	1426	1824	Vpeak
Highest Allowable Overvoltage (Transient Overvoltage $t_{ini} = 60$ sec)	$V_{IOTM}$	6000	8000	Vpeak
Safety-limiting values - maximum values allowed in the event of a failure.				
Case Temperature	$T_S$	175		°C
Input Current	$I_{S,INPUT}$	230		mA
Output Power	$P_{S,OUTPUT}$	600		mW
Insulation Resistance at $T_S$ , $V_{IO} = 500$ V	RS	$> 10^9$		$\Omega$

\* Refer to the optocoupler section of the Isolation and Control Components Designer's Catalog, under Product Safety Regulations section, (IEC/EN/DIN EN 60747-5-5) for a detailed description of Method a and Method b partial discharge test profiles.

**Table 2. Insulation and Safety Related Specifications**

Parameter	Symbol	ACPL-P480	ACPL-W480	Units	Conditions
Minimum External Air Gap (External Clearance)	L(101)	7.0	8.0	mm	Measured from input terminals to output terminals shortest distance through air.
Minimum External Tracking (External Creepage)	L(102)	8.0	8.0	mm	Measured from input terminals to output terminals shortest distance path along body.
Minimum Internal Plastic Gap (Internal Clearance)			0.08	mm	Through insulation distance conductor to conductor, usually the straight line distance thickness between the emitter and detector.
Minimum Internal Tracking (Internal Creepage)			NA	mm	Measured from input terminals to output terminals, along internal cavity.
Tracking Resistance (Comparative Tracking Index)	CTI		>175	V	DIN IEC 112/VDE 0303 Part 1
Isolation Group			IIIa		Material Group (DIN VDE 0110, 1/89, Table 1)

**Table 3. Absolute Maximum Ratings**

Parameter	Symbol	Min.	Max.	Units	Note
Storage Temperature	$T_S$	-55	125	°C	
Operating Temperature	$T_A$	-40	100	°C	
Average Input Current	$I_{F(avg)}$		10	mA	
Peak Transient Input Current ( $<1 \mu s$ pulse width, 300 pps) ( $<200 \mu s$ pulse width, $< 1\%$ duty cycle)	$I_{F(tran)}$		1.0 40	A mA	
Reverse Input Voltage	$V_R$		5	V	
Average Output Current	$I_O$		25	mA	
Supply Voltage	$V_{CC}$	0	25		
Output Voltage	$V_O$	-0.5	25		
Total Package Power Dissipation	$P_T$		210	mW	1

**Table 4. Recommended Operating Conditions**

Parameter	Symbol	Min.	Max.	Units	Note
Power Supply Voltage	$V_{CC}$	4.5	20	V	
Forward Input Current (ON)	$I_{F(ON)}$	6	10	mA	
Forward Input Voltage (OFF)	$V_{F(OFF)}$	-	0.8	V	
Operating Temperature	$T_A$	-40	100	°C	

Notes:

- Derate total package power dissipation,  $P_T$ , linearly above 70°C free-air temperature at a rate of 4.5 mW/°C.

**Table 5. Electrical Specifications**

Over recommended operating conditions  $T_A = -40\text{ }^\circ\text{C}$  to  $100\text{ }^\circ\text{C}$ ,  $V_{CC} = +4.5\text{ V}$  to  $20\text{ V}$ ,  $I_{F(ON)} = 6\text{ mA}$  to  $10\text{ mA}$ ,  $V_{F(OFF)} = 0\text{ V}$  to  $0.8\text{ V}$ , unless otherwise specified. All typicals at  $T_A = 25\text{ }^\circ\text{C}$ .

Parameter	Symbol	Min.	Typ.	Max.	Units	Test Conditions	Fig.	Note
Logic Low Output Voltage	$V_{OL}$			0.5	V	$I_{OL} = 6.4\text{ mA}$	1, 3, 9, 10	
Logic High Output Voltage ACPL-P480 ACPL-W480	$V_{OH}$	2.4 2.7 2.7	$V_{CC} - 1.1$		V	$I_{OH} = -2.6\text{ mA}$ $I_{OH} = -0.4\text{ mA}$ $I_{OH} = -1.6\text{ mA}$	2, 3, 7, 9, 10	
Threshold Input Current Low to High	$I_{FLH}$		2.2	5.5	mA			
Output Leakage Current ( $V_O = V_{CC} + 0.5\text{ V}$ )	$I_{OHH}$			100 500	$\mu\text{A}$ $\mu\text{A}$	$V_{CC} = 5\text{ V}$ , $I_F = 10\text{ mA}$ $V_{CC} = 20\text{ V}$ , $I_F = 10\text{ mA}$		
Logic Low Supply Current	$I_{CCL}$		1.9 2.0	3.0 3.0	mA mA	$V_{CC} = 5.5\text{ V}$ , $V_F = 0\text{ V}$ , $I_O = \text{Open}$ $V_{CC} = 20\text{ V}$ , $V_F = 0\text{ V}$ , $I_O = \text{Open}$		
Logic High Supply Current	$I_{CCH}$		1.5 1.6	2.5 2.5	mA mA	$V_{CC} = 5.5\text{ V}$ , $I_F = 10\text{ mA}$ , $I_O = \text{Open}$ $V_{CC} = 20\text{ V}$ , $I_F = 10\text{ mA}$ $I_O = \text{Open}$		
Logic Low Short Circuit Output Current	$I_{OSL}$	25 50			mA mA	$V_O = V_{CC} = 5.5\text{ V}$ , $V_F = 0\text{ V}$ $V_O = V_{CC} = 20\text{ V}$ , $V_F = 0\text{ V}$		1
Logic High Short Circuit Output Current	$I_{OSH}$			-25 -50	mA mA	$V_{CC} = 5.5\text{ V}$ , $I_F = 6\text{ mA}$ , $V_O = \text{GND}$ $V_{CC} = 20\text{ V}$ , $I_F = 6\text{ mA}$ , $V_O = \text{GND}$		1
Input Forward Voltage	$V_F$		1.5	1.7 1.85	V V	$T_A = 25\text{ }^\circ\text{C}$ , $I_F = 6\text{ mA}$ $I_F = 6\text{ mA}$	4	
Input Reverse Breakdown Voltage	$BV_R$	5			V	$I_R = 10\text{ }\mu\text{A}$		
Input Diode Temperature Coefficient	$\Delta V_F / \Delta T_A$		1.7		mV/ $^\circ\text{C}$	$I_F = 6\text{ mA}$		
Input Capacitance	$C_{IN}$		60		pF	$f = 1\text{ MHz}$ , $V_F = 0\text{ V}$		2

## Notes:

1. Duration of output short circuit time should not exceed 10 ms.
2. Input capacitance is measured between pin 1 and pin 3.

**Table 6. Switching Specifications**

Over recommended operating conditions  $T_A = -40\text{ }^\circ\text{C}$  to  $100\text{ }^\circ\text{C}$ ,  $V_{CC} = +4.5\text{ V}$  to  $20\text{ V}$ ,  $I_{F(ON)} = 6\text{ mA}$  to  $10\text{ mA}$ ,  $V_{F(OFF)} = 0\text{ V}$  to  $0.8\text{ V}$ , unless otherwise specified. All typicals at  $T_A = 25\text{ }^\circ\text{C}$ .

Parameter	Symbol	Min.	Typ.	Max.	Units	Test Conditions	Fig.	Note
Propagation Delay Time to Logic Low Output Level	$t_{PHL}$		150	350	ns	With Peaking Capacitor	5, 6	1
Propagation Delay Time to Logic High Output Level	$t_{PLH}$		110	350	ns	With Peaking Capacitor	5, 6	1
Pulse Width Distortion	$ t_{PHL} - t_{PLH} $ = PWD			250	ns			2
Propagation Delay Difference Between Any 2 Parts	PDD	-100		250	ns			3
Output Rise Time (10-90%)	$t_r$		16		ns		5, 8	
Output Fall Time (90-10%)	$t_f$		20		ns		5, 8	
Logic High Common Mode Transient Immunity	$ CM_H $	20			kV/ $\mu$ s	$ V_{CM}  = 1000\text{ V}$ , $I_F = 6.0\text{ mA}$ , $V_{CC} = 5\text{ V}$ , $T_A = 25\text{ }^\circ\text{C}$	11	4
Logic Low Common Mode Transient Immunity	$ CM_L $	20			kV/ $\mu$ s	$ V_{CM}  = 1000\text{ V}$ , $V_F = 0\text{ V}$ , $V_{CC} = 5\text{ V}$ , $T_A = 25\text{ }^\circ\text{C}$	11	4

**Table 7. Package Characteristics**

Parameter	Symbol	Min.	Typ.	Max.	Units	Test Conditions	Fig.	Note
Input-Output Momentary Withstand Voltage*	$V_{ISO}$	3750**			$V_{rms}$	$RH < 50\%$ , $t = 1\text{ min.}$ $T_A = 25\text{ }^\circ\text{C}$		5, 6
Input-Output Resistance	$R_{I-O}$		$10^{12}$			$V_{I-O} = 500\text{ Vdc}$		5
Input-Output Capacitance	$C_{I-O}$		0.6			$f = 1\text{ MHz}$ , $V_{I-O} = 0\text{ Vdc}$		5

\* The Input-Output Momentary Withstand Voltage is a dielectric voltage rating that should not be interpreted as an input-output continuous voltage rating. For the continuous voltage rating refer to the IEC/EN/DIN EN 60747-5-2 Insulation Characteristics Table (if applicable).

\*\* For all ACPL-P480 devices except Option 020

\*\*\* For ACPL-W480 and Option 020 of ACPL-P480)

Notes:

1. The  $t_{PLH}$  propagation delay is measured from the 50% point on the leading edge of the input pulse to the 1.3 V point on the leading edge of the output pulse. The  $t_{PHL}$  propagation delay is measured from the 50% point on the trailing edge of the input pulse to the 1.3 V point on the trailing edge of the output pulse.
2. Pulse Width Distortion (PWD) is defined as  $|t_{PHL} - t_{PLH}|$  for any given device.
3. The difference between  $t_{PLH}$  and  $t_{PHL}$  between any two devices under the same test condition.
4.  $CM_H$  is the maximum slew rate of the common mode voltage that can be sustained with the output voltage in the logic high state,  $V_O > 2.0\text{ V}$ .  $CM_L$  is the maximum slew rate of the common mode voltage that can be sustained with the output voltage in the logic low state,  $V_O < 0.8\text{ V}$ .
5. Device considered a two-terminal device: pins 1, 2 and 3 shorted together and pins 4, 5 and 6 shorted together.
6. In accordance with UL 1577, each optocoupler is proof tested by applying an insulation test voltage  $\geq 4500\text{ V}_{RMS}$  for one second (leakage detection current limit,  $I_{I-O} \leq 5\text{ }\mu\text{A}$ ).; each optocoupler with option 020 is proof tested by applying an insulation test voltage  $\geq 6000\text{ V}_{RMS}$  for 1 second (leakage detection current limit,  $I_{I-O} \leq 5\text{ }\mu\text{A}$ ). This test is performed before the 100% production test for partial discharge (Method b) shown in the IEC/EN/DIN EN 60747-5-2 Insulation Characteristics Table, if applicable.
7. Use of a  $0.1\text{ }\mu\text{F}$  bypass capacitor connected between pins 4 and 6 is recommended.

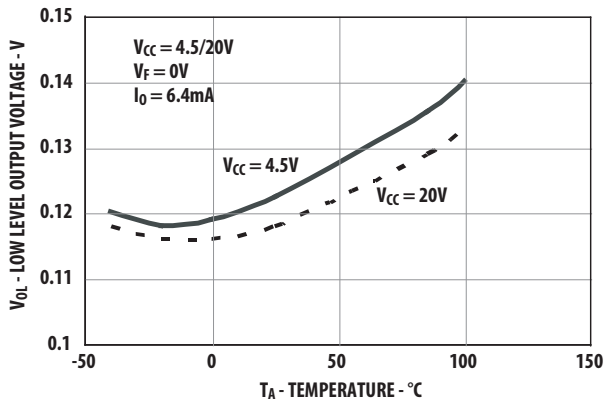


Figure 1. Typical Logic Low Output Voltage vs. Temperature

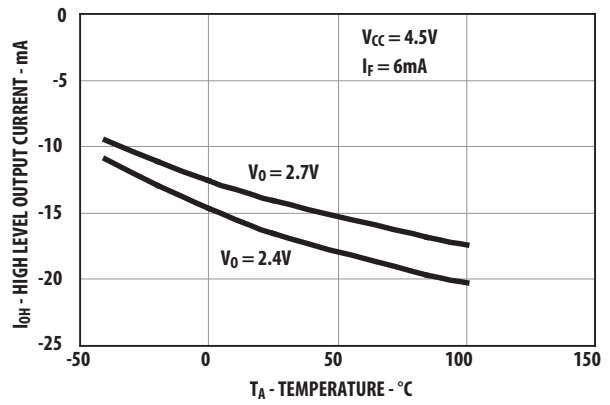


Figure 2. Typical Logic High Output Current vs. Temperature

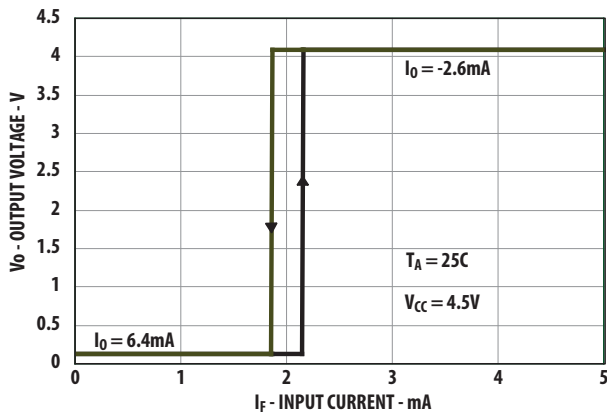


Figure 3. Typical Output Voltage vs. Forward Input Current

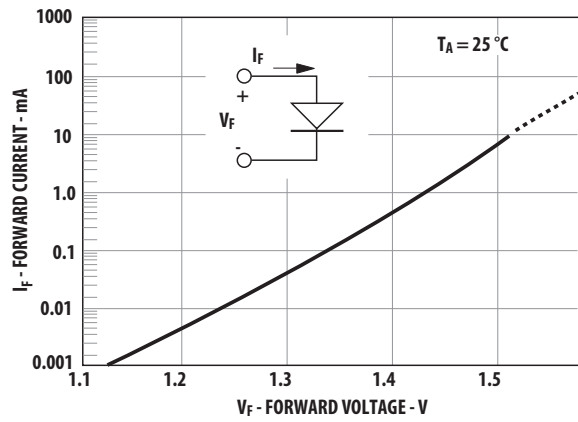


Figure 4. Typical Input Diode Forward Characteristic

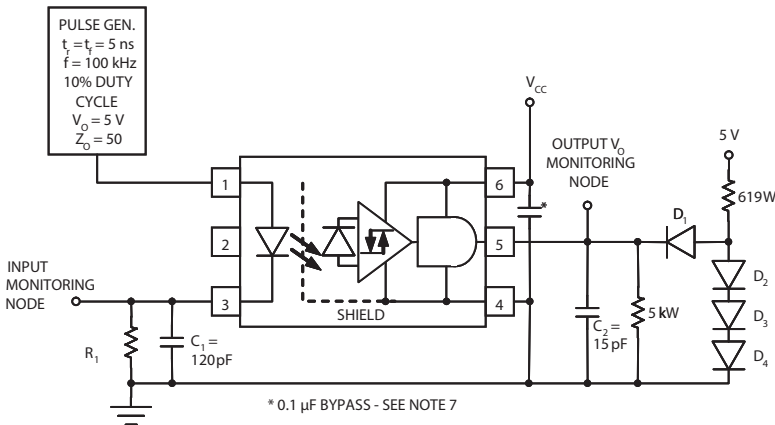
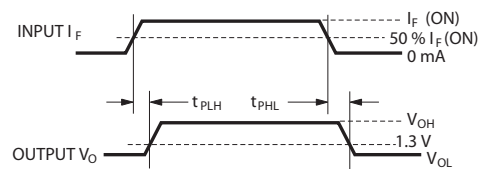


Figure 5. Circuit for  $t_{PLH}$ ,  $t_{PHL}$ ,  $t_r$ ,  $t_f$

THE PROBE AND JIG CAPACITANCES ARE INCLUDED IN  $C_1$  AND  $C_2$ .

$R_1$	580 W	330 W
$I_{F(ON)}$	6 mA	10 mA

ALL DIODES ARE 1N916 OR 1N3064.





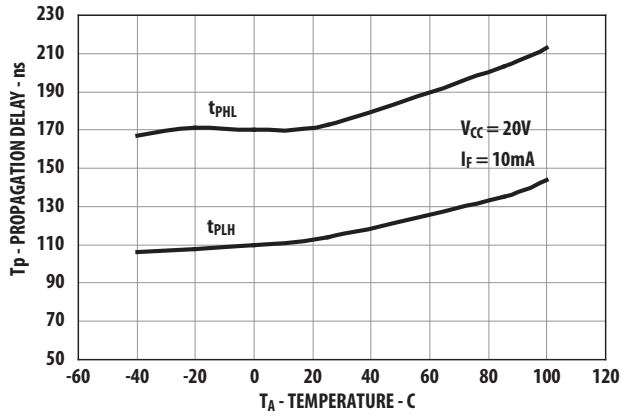


Figure 6. Typical Propagation Delays vs. Temperature.

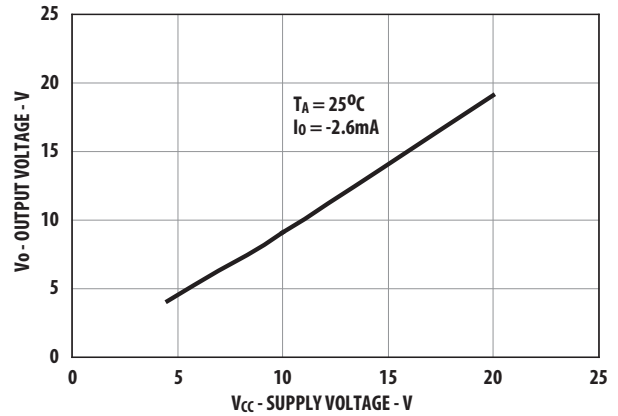


Figure 7. Typical Logic High Output Voltage vs. Supply Voltage

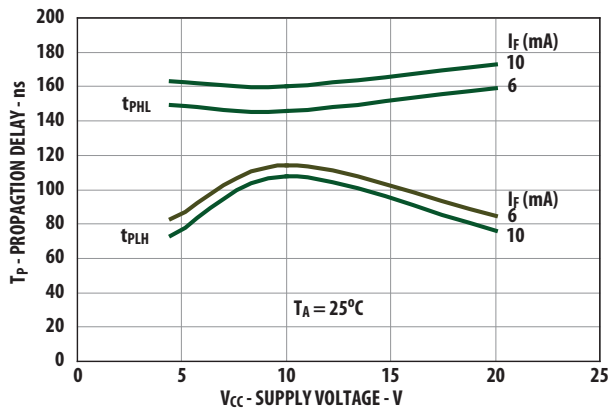


Figure 8. Typical Propagation Delay vs. Supply Voltage

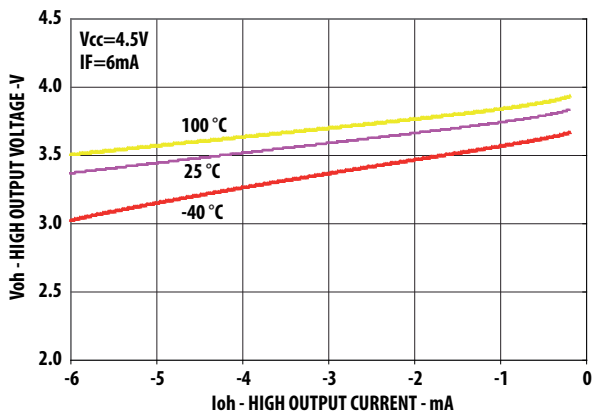


Figure 9.  $V_{oh}$  vs  $I_{oh}$  Across Temperatures

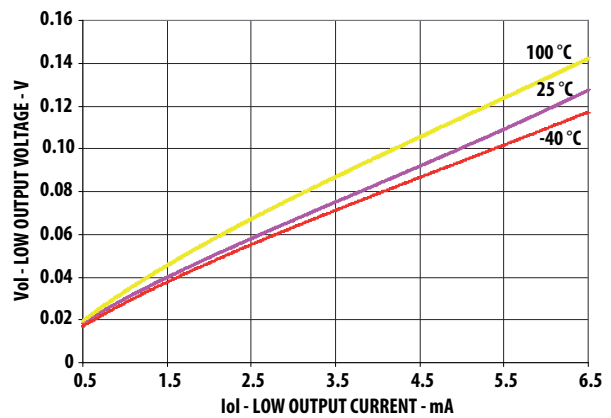
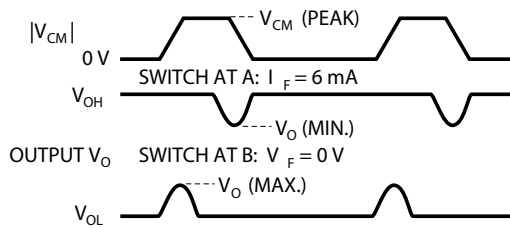
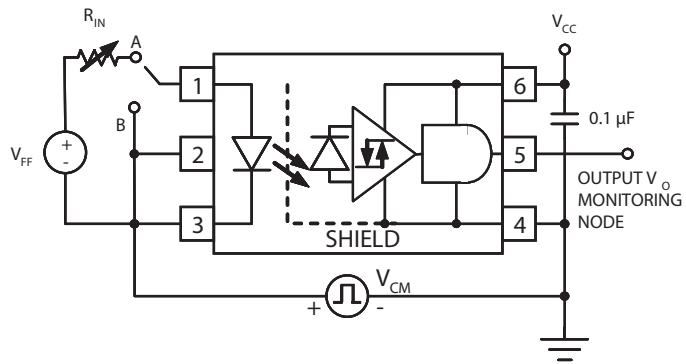


Figure 10.  $V_{ol}$  vs  $I_{ol}$  Across Temperatures



**Figure 11. Test Circuit for Common Mode Transient Immunity and Typical Waveforms**

For product information and a complete list of distributors, please go to our web site: [www.avagotech.com](http://www.avagotech.com)

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